Precise measurements of the *D* meson lifetimes

N. K. Nisar ^{1,*}

^aBrookhaven National Laboratory, Upton, New York, 11973

E-mail: nnellikun@bnl.gov

We report the result of D^0 and D^+ lifetime measurement using $D^0 \to K^-\pi^+$ and $D^+ \to K^-\pi^+\pi^+$ decays reconstructed using 72 fb⁻¹ of data collected by the Belle II experiment at SuperKEKB asymmetric-energy e^+e collider. The results, $\tau(D^0)=410.5\pm1.1({\rm stat})\pm0.8({\rm syst})$ fs and $\tau(D^+)=1030.4\pm4.7({\rm stat})\pm3.1({\rm syst})$ fs are the most precise to date and are consistent with previous measurements.

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^{*}Speaker

1. Introduction

Accurate prediction of charm meson lifetime is challenging due to the contributions of strong-interaction to the decay amplitudes and it is an important ingredient to many theoretical calculations as well as experimental measurements. The predictions must resort to effective models, such as the heavy-quark expansion [1–6] and precise lifetime measurements provide excellent tests of such models. The lifetime measurement with early Belle II data will demonstrate the excellent vertexing capability of the Belle II detector which is essential for future analyses of decay-time-dependent effects.

In this paper, we report the measurement of D^0 and D^+ lifetimes by reconstructing $D^{*+} \to (D^0 \to K^-\pi^+)\pi^+$ and $D^{*+} \to (D^+ \to K^-\pi^+\pi^+)\pi^0$ decays using 72 fb⁻¹ of data collected by Belle II detector [7](Charge-conjugate decays are implied throughout). The D^{*+} tagging is requested to suppress the combinatoric background. In SuperKEKB [8], the D^{*+} mesons are produced with a boost that displace the D^0 and D^+ mesons. The decay time estimated from the projection of this displacement on to the direction of momentum, \vec{p} , as $t = m_D \vec{L} \cdot \vec{p}/|\vec{p}|^2$, where m_D is the known mass of the relevant D meson [9]. The uncertainty in decay-time, σ_t , is estimated by propagating the uncertainties in \vec{L} and \vec{p} , including their correlations.

2. Belle II detector

The Belle II detector is built around the interaction region of SuperKEKB e^+e^- collider. The inner most part is a two-layer silicon-pixel detector (PXD) followed by a four-layer double-sided silicon-strip detector (SVD) and a central drift chamber (CDC) together form the tracking system. A time-of-propagation counter and an aerogel ring-imaging Cherenkov counter that cover the barrel and forward end-cap regions of the detector, respectively, are used for charged-particle identification. An electromagnetic calorimeter is used to reconstruct photons and electrons. All these components are kept inside a 1.5 T magnetic field. A dedicated system to identify K_L^0 mesons and muons is installed in the outermost part of the detector.

3. Reconstruction

 $D^0 o K^-\pi^+$ and $D^+ o K^-\pi^+\pi^+$ candidates are reconstructed using charged charged tracks identified as kaons and pions. Each track is required to have at-least one hit in the first layer of PXD, one hit in the SVD. Tracks from $D^0(D^+)$ need to have at least 20 (30) hits in the CDC. The low momentum π^+ from the D^{*+} decay are tracks consistent with originating from the interaction region that have at least one hit in the SVD and one hit in the CDC. Low momentum π^0 is reconstructed from two photons as, $\pi^0 \to \gamma\gamma$. The D^{*+} momentum in e^+e^- centre-of-mass frame is required be greater than 2.5(2.6) GeV/c to suppress $D^0(D^+)$ mesons coming from bottom mesons. A global decay-chain vertex fit [10] constrains the tracks according to the decay topology is applied and only candidates with fit χ^2 probabilities larger than 0.01 are retained for further analysis. The mass of D^0 and D^+ candidate is required to be 1.75 < $m(K^-\pi^+)$ < 2.00 GeV/ c^2 . The difference between the D^{*+} and D candidate masses, ΔM , must satisfy 144.94 < ΔM < 145.90 MeV/ c^2 and 138 < ΔM < 143 MeV/ c^2 for D^0 and D^+ candidates, respectively. By applying these selections,

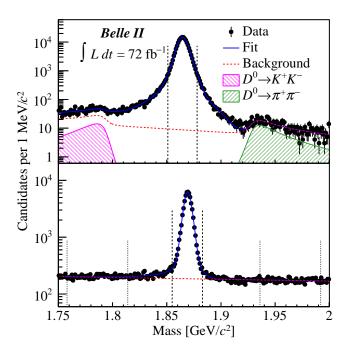


Figure 1: Mass distributions of (top) $D^0 \to K^-\pi^+$ and (bottom) $D^+ \to K^-\pi^+\pi^+$ candidates with fit projections overlaid. The vertical dashed and (for the bottom plot) dotted lines indicate the signal regions and the sideband, respectively.

approximately 171×10^3 signal D^0 candidates with signal purity of 99.8% is observed in the signal region, defined as $1.815 < m(K^-\pi^+) < 1.878 \text{ GeV}/c^2$. The signal region in $m(K^-\pi^+\pi^+)$ is defined as $1.855 < m(K^-\pi^+\pi^+) < 1.883 \text{ GeV}/c^2$ and contains approximately 59×10^3 signal candidates with a background contamination of 9%. Mass distributions of $D^0 \to K^-\pi^+$ and $D^+ \to K^-\pi^+\pi^+$ candidates are shown in Fig. 1.

4. Lifetime fit

Lifetimes are extracted by using unbinned maximum-likelihood fits to the (t, σ_t) distributions of candidates populating the signal regions. The signal probability-density function (PDF) is the convolution of an exponential function in t with a resolution function that depends on σ_t , multiplied by the PDF of σ_t . The PDF of σ_t is a histogram template derived directly from the data. Simulation shows that a double (single) Gaussian with common mean will describe the resolution function for $D^0(D^+)$. The mean of the resolution function is allowed to float in the fit to account for a possible bias in the determination of the decay time; the width is the per-candidate σ_t scaled by a free parameter s to account for a possible misestimation of the decay-time uncertainty.

In the D^0 case, the per-mille-level fraction of background candidates in the signal region is neglected and a systematic uncertainty is assigned for this. A sizable background contamination is accounted for in the D^+ case using the data side-bands: $1.758 < m(K^-\pi^+\pi^+) < 1.814, 1.936 < m(K^-\pi^+\pi^+) < 1.992 \, \text{GeV}/c^2$. The background PDF consists of a zero-lifetime component and two exponential components, all convoluted with a Gaussian resolution function having a free mean and a width corresponding to $s\sigma_t$. To better constrain the background parameters, a simultaneous

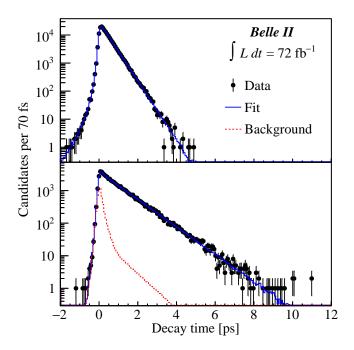


Figure 2: Decay-time distributions of (top) $D^0 \to K^-\pi^+$ and (bottom) $D^+ \to K^-\pi^+\pi^+$ candidates in their respective signal regions with fit projections overlaid.

Source	$\tau(D^0 \to K^- \pi^+)$ [fs]	$\tau(D^+ \to K^- \pi^+ \pi^+)$ [fs]
Resolution model	0.16	0.39
Backgrounds	0.24	2.52
Detector alignment	0.72	1.70
Momentum scale	0.19	0.48
Total	0	0

Table 1: Systematic uncertainties.

fit to the candidates in the signal region and sideband is performed by constraining the background fraction obtained from a fit to $m(K^-\pi^+\pi^+)$.

The lifetime fits are tested on simulated samples and the returned lifetimes are consistent with the true values. The decay-time distributions of the data, with fit projections overlaid, are shown in Fig. 2. The D^0 and D^+ lifetimes are measured to be $410.5 \pm 1.1(\text{stat}) \pm 0.8(\text{syst})$ fs and $1030.4 \pm 4.7(\text{stat}) \pm 3.1(\text{syst})$ fs, respectively [11]. The results are consistent with their respective world average values [9]. The systematic uncertainties are summarized in Table 1 and the total systematic uncertainty is the sum in quadrature of the individual components.

5. Systematic Uncertainty

A small correlation between t and σ_t is neglected in our nominal fitting model. In-order to quantify the effect 1000 signal-only samples of simulated events with same statistics as data are fitted with the nominal PDF. Upper bounds of 0.16 fs and 0.39 fs on the average absolute deviation

of measured lifetimes from their true value is assigned as a systematic uncertainty due to imperfect resolution for $D^0 \to K^-\pi^+$ and $D^+ \to K^-\pi^+\pi^+$, respectively.

A background contamination of 0.2% is neglected in the signal region of $D^0 \to K^-\pi^+$. To estimate the effect on our result, 500 simulated samples of e^+e^- events with same size and signal-to-background ratio as data are fitted with the nominal model. The average absolute deviation of fitted lifetime, after subtracting the uncertainty due Resolution modeling, from the true value is 0.24 fs and assigned as systematic uncertainty due to background contamination.

The background in $D^+ \to K^- \pi^+ \pi^+$ signal region is modeled using data side band. A mismatch between data and simulation in the side band may be indicating an imperfect description of background components in signal region by the side band. 1000 samples prepared using pseudo experiments in signal region and simulated data in side band reproduce the same level of disagreement is fitted and the absolute average difference between the measured and simulated lifetime, 2.52 fs, is assigned as the systematic uncertainty due to background modeling.

Misalignment of tracking detectors may cause bias in the decay-length determination and hence the lifetime. Two sources of uncertainties associated with the alignment are considered: the statistical precision and a possible systematic bias. The day-to-day difference between alignments in real data is used for the statistical contribution. Samples of same statistics as data are simulated by introducing realistic misalignment effects and the difference in lifetime residual for a given misalignment configuration and that from a perfectly aligned sample is assigned as systematic uncertainty.

6. Conclusions

In conclusion, the D^0 and D^+ lifetimes are measured using the data collected by the Belle II experiment corresponding to an integrated luminosity of 72 fb⁻¹. The results are most precise to date and are consistent with previous measurements.

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